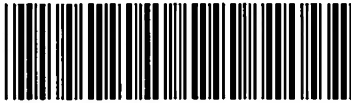


**Search Notes**

Application/Control No.

10/530,572

Examiner

Jennifer Y. Cho

Applicant(s)/Patent under  
Reexamination

REIFFENRATH ET AL.

Art Unit

1621

**SEARCHED**

Class	Subclass	Date	Examiner
568	642	1/16/2007	JC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC Search	1/9/2007	PS
East Search	1/11/2007	JC